## DS - 03/26/2224ECTRONIC INFORMATION DISCLOSURE STATEMENT

## Electronic Version v18

Stylesheet Version v18.0

Title of Invention

IC DESIGN DENSITY CHECKING METHOD, SYSTEM AND PROGRAM PRODUCT

**Application Number:** 

10/708,820

Confirmation Number:

First Named Applicant:

William DeCamp

Attorney Docket Number:

BUR920030164US1

Art Unit:

2825

Examiner:

Paul Dinh

Search string:

( 6493658 or 6189130 or 6134702 or 20020066064 ).pn

## **US Patent Documents**

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass
PD	1	6493658	2002-12-10	Koford et al.			
PD	2	6189130	<del>2002-05-30</del>	Gofman et al.	2001-2-13		
PD	3	6134702	2000-10-17	Scepanovic et al.			

## **US Published Applications**

Note: Applicant is not required to submit a paper copy of cited US Published Applications

init	Cite.No.	Pub. No.	Date	Applicant	Kind	Class	Subclass
PD	1	20020066064	2002-05-03	Kamath et al.			
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Examiner Name	Date
/Paul Dinh/	05/09/2006

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